## Notice of R ferences Cited Application/Control No. 09/810,828 Examiner Thomas R Artman Applicant(s)/Patent Under Reexamination ZARRABIAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS OF Name

Name

Classification

Classification

Classification

Classification

Copy 385/31 Document Number Date Classification Country Code-Number-Kind Code MM-YYYY 10-2000 US-6,130,971 Α US-6,278,549 08-2001 Gaebe, Carl E. 359/584 В 356/519 11-2000 С US-6,151,114 Russell, James C. 356/419 US-5,166,755 11-1992 Gat, Nahum D US-Ε US-F US-G н US-1 US-US-J US-Κ US-L М US-

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р				·	
	Q					
	R					
	S			-		
	Т				, , ,	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
*	U	Takashashi, Haruo. "Temperature stability of thin-film narrow-bandpass filters produced by ion-assisted deposition."□□□□Applied Optics, Vol. 34, No. 4, Feb.1, 1995, pp.667-675					
	V						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.